

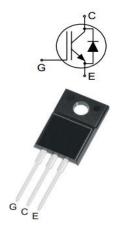
IGBT

Features

- 600V,25A
- V_{CE(sat)(typ.)}=2.1V@V_{GE}=15V,I_C=25A
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA



JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as SMPS, general inverter and other switching applications.



Absolute Maximum Ratings

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	600	V
V _{GES}	Gate-Emitter Voltage	<u>+</u> 30	V
Ic	Continuous Collector Current (Tc=25 °C)	45	А
	Continuous Collector Current (Tc=100°C)	25	А
Ісм	Pulsed Collector Current (Note 1)	75	А
l _F	Diode Continuous Forward Current (T _C =100 °C)	25	А
I _{FM}	Diode Maximum Forward Current (Note 1)	75	А
t _{sc}	Short Circuit Withstand Time	10	us
P _D	Maximum Power Dissipation (T _C =25 °C)	42	W
	Maximum Power Dissipation (T _C =100°C)	17	W
TJ	Operating Junction Temperature Range	-55 to +150	$^{\circ}$
T _{STG}	Storage Temperature Range	-55 to +150	°C

Thermal Characteristics

Symbol	Parameter	Max.	Units
R _{th j-c}	Thermal Resistance, Junction to case for IGBT	3.0	°C/ W
R _{th j-c}	Thermal Resistance, Junction to case for Diode	2.9	°C/ W
R _{th j-a}	Thermal Resistance, Junction to Ambient	65	°C/ W



JNG25T60FS

Electrical Characteristics (Tc=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV _{CES}	Collector-Emitter Breakdown Voltage	$V_{GE} = 0V, I_{C} = 250uA$	600	-	-	V
I _{CES}	Collector-Emitter Leakage Current	$V_{CE} = 600V, V_{GE} = 0V$	-	-	100	uA
I _{GES}	Gate Leakage Current, Forward	V_{GE} =30V, V_{CE} = 0V	-	-	100	nA
	Gate Leakage Current, Reverse	V_{GE} = -30V, V_{CE} = 0V	-	-	100	nA
$V_{\text{GE(th)}}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$, $I_{C} = 250uA$	4.5	-	6.5	V
$V_{\text{CE(sat)}}$	Collector-Emitter Saturation Voltage	V _{GE} =15V, I _C = 25A	-	2.1	2.6	V
Qg	Total Gate Charge	Vcc=400V	-	62		nC
Q _{ge}	Gate-Emitter Charge	V _{GE} =15V I _C =25A	-	8		nC
Qgc	Gate-Collector Charge		-	32		nC
t _{d(on)}	Turn-on Delay Time	V _{CC} =400V V _{GE} =15V I _C =25A R _G =28Ω Inductive Load T _C =25 °C	-	20	-	ns
t _r	Turn-on Rise Time		-	27	-	ns
t d(off)	Turn-off Delay Time		-	200	-	ns
t f	Turn-off Fall Time		-	24	-	ns
Eon	Turn-on Switching Loss		-	0.65	-	mJ
Eoff	Turn-off Switching Loss		-	0.28	-	mJ
Ets	Total Switching Loss		-	0.93	-	mJ
C _{ies}	Input Capacitance	V _{CE} =25V V _{GE} =0V f = 1MHz	-	900	-	pF
Coes	Output Capacitance		-	285	-	pF
C _{res}	Reverse Transfer Capacitance		-	70	-	pF

Electrical Characteristics of Diode (Tc=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V _F	Diode Forward Voltage	I _F =25A	1	1.5	2.0	V
trr	Diode Reverse Recovery Time	V _{CE} = 400V	•	85		ns
Irr	Diode peak Reverse Recovery Current	I _F = 25A	1	14		Α
Q _{r r}	Diode Reverse Recovery Charge	dlf/dt = 200A/us	-	200		nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



Typical Performance Characteristics

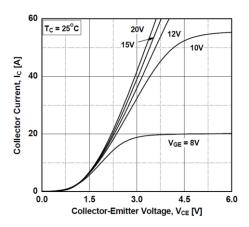


Fig 1. Output characteristics

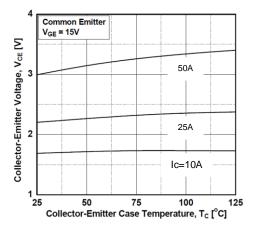


Figure 3. Saturation Voltage vs. Case Temperature at Variant Current Level

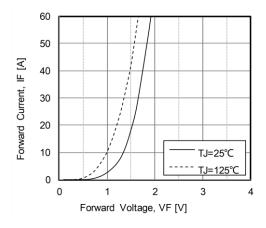


Figure 5. Forward Characteristics

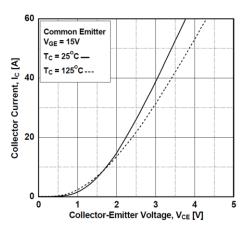


Fig 2. Typical Saturation Voltage Characteristics

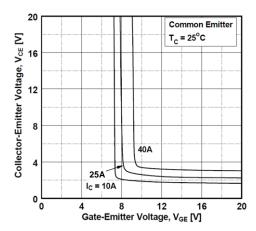


Figure 4. Saturation Voltage vs. VGE

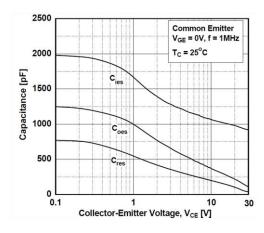


Figure 6. Capacitance Characteristics



Typical Performance Characteristics

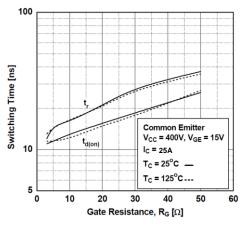


Figure 7. Turn-On Characteristics vs. Gate Resistance

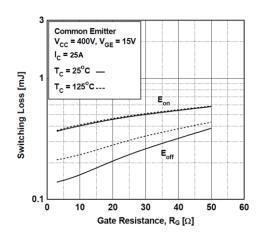


Figure 9. Switching Loss vs. Gate Resistance

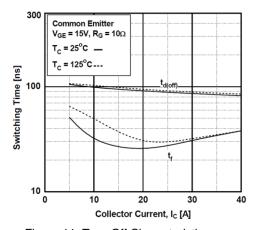


Figure 11. Turn-Off Characteristics vs. Collector Current

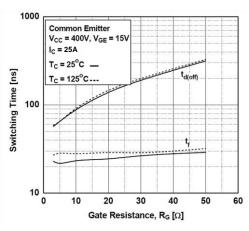


Figure 8. Turn-Off Characteristics vs. Gate Resistance

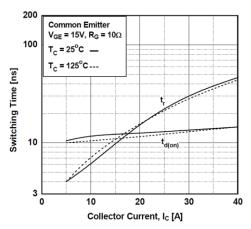


Figure 10. Turn-On Characteristics vs. Collector Current

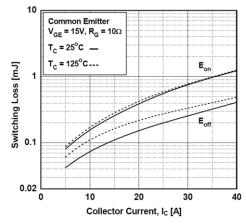


Figure 12. Switching Loss vs. Collector Current



Typical Performance Characteristics

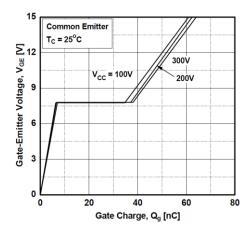


Figure 13. Gate Charge Characteristics

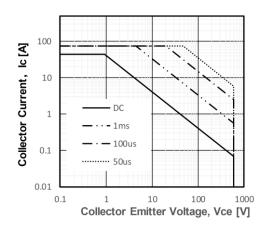


Figure 14. SOA Characteristics

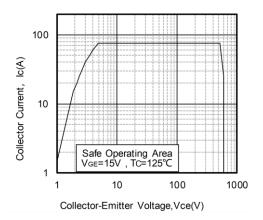


Figure 15. Turn-Off SOA

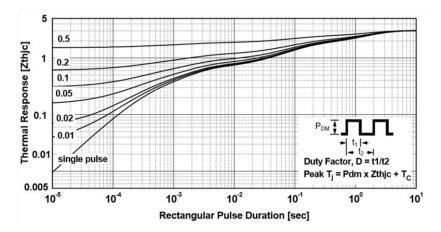
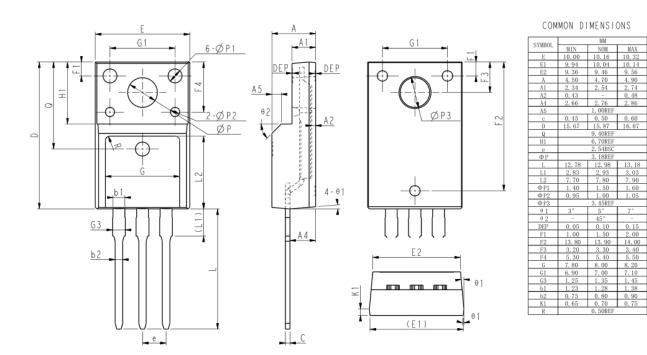


Figure 19. Transient Thermal Impedance of IGBT





封装外型





JNG25T60FS

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